## Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10773480	DIB ET AL.
Examiner	Art Unit
Kim, Jennifer	1617

SEARCHED				
Class	Subclass	Date	Examiner	
514	226.2	7/23/2007	jmk	
	Updated	5/22/2008	jmk	
	Updated	1/9/2009	jmk	

SEARCH NOTES				
Search Notes	Date	Examiner		
STIC; inventor serach; STN (registry, medicine)	7/23/2007	jmk		
Updated	5/22/2008	jmk		
Updated	1/9/2009	jmk		

INTERFERENCE SEARCH					
Class		Subclass	Date	Examiner	
514	226.2		1/9/2009	jmk	

U.S. Patent and Trademark Office Part of Paper No.: 20090109